Search Notes						

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/023,974	KUMAR ET AL.	
Examiner	Art Unit	
Binh Q. Nguyen	2664	

	SEAR	CHED	
Class	Subclass	Date	Examiner
370	352	9/7/2005	BQN
370	355	9/7/2005	BQN
370	468	9/7/2005	BQN
370	470	9/7/2005	BQN
370	354	9/6/2005	BQN
370	353	9/8/2005	BQN

INI	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST (US-PGPUB; USPAT; USOSR; EPO; JPO; DERWENT; IBM-TDB) see history search note	9/7/2005	BQN
Consulted with Wellington Chin	9/7/2005	BQN
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